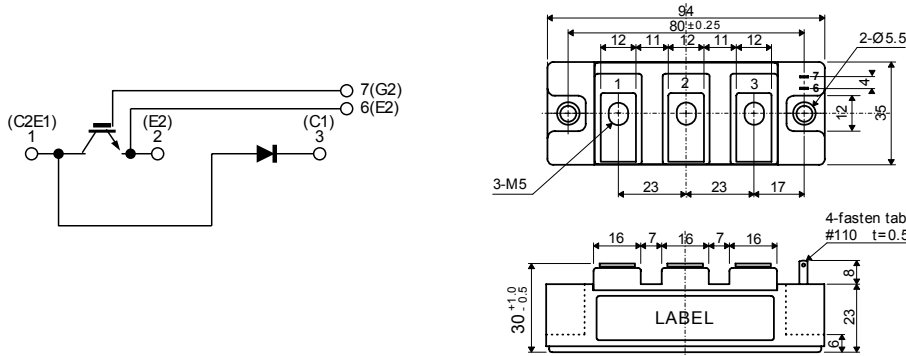


□ 回路図 : *CIRCUIT*

□ 外形寸法図 : *OUTLINE DRAWING*



Dimension: [mm]

□ 最大定格 : *MAXIMUM RATINGS* ( $T_c = 25^\circ\text{C}$ )

Item	Symbol	Rated Value	Unit
コレクタ・エミッタ間電圧 Collector-Emittter Voltage	$V_{CES}$	600	V
ゲート・エミッタ間電圧 Gate-Emittter Voltage	$V_{GES}$	$\pm 20$	V
コレクタ電流 Collector Current	DC	50	A
	1ms	100	
コレクタ損失 Collector Power Dissipation	$P_C$	250	W
接合温度 Junction Temperature Range	$T_j$	$-40 \sim +150$	$^\circ\text{C}$
保存温度 Storage Temperature Range	$T_{stg}$	$-40 \sim +125$	$^\circ\text{C}$
絶縁耐圧(Terminal to Base AC, 1 minute) Isolation Voltage	$V_{ISO}$	2,500	$V_{(RMS)}$
締め付けトルク Mounting Torque	Module Base to Heatsink	2	N·m (kgf·cm)
	Busbar to Main Terminal	2 (20.4)	

□ 電気的特性 : *ELECTRICAL CHARACTERISTICS* ( $T_c = 25^\circ\text{C}$ )

Characteristic	Symbol	Test Condition	Min.	Typ.	Max.	Unit
コレクタ遮断電流 Collector-Emittter Cut-Off Current	$I_{CES}$	$V_{CE} = 600V, V_{GE} = 0V$	—	—	1.0	mA
ゲート漏れ電流 Gate-Emittter Leakage Current	$I_{GES}$	$V_{GE} = \pm 20V, V_{CE} = 0V$	—	—	1.0	$\mu\text{A}$
コレクタ・エミッタ間飽和電圧 Collector-Emittter Saturation Voltage	$V_{CE(sat)}$	$I_C = 50A, V_{GE} = 15V$	—	2.1	2.6	V
ゲートしきい値電圧 Gate-Emittter Threshold Voltage	$V_{GE(th)}$	$V_{CE} = 5V, I_C = 50mA$	4.0	—	8.0	V
入力容量 Input Capacitance	$C_{ies}$	$V_{CE} = 10V, V_{GE} = 0V, f = 1MHz$	—	2,500	—	pF
スイッチング時間 Switching Time	上昇時間 Rise Time	$V_{CC} = 300V$ $R_L = 6.0\Omega$ $R_G = 20.0\Omega$ $V_{GE} = \pm 15V$	—	0.15	0.30	$\mu\text{s}$
	ターンオン時間 Turn-on Time		—	0.25	0.40	
	下降時間 Fall Time		—	0.10	0.35	
	ターンオフ時間 Turn-off Time		—	0.35	0.70	

□ フリーホイールダイオードの特性 : *FREE WHEELING DIODE RATINGS & CHARACTERISTICS* ( $T_c = 25^\circ\text{C}$ )

Item	Symbol	Rated Value	Unit
順電流 Forward Current	DC	50	A
	1ms	100	

Characteristic	Symbol	Test Condition	Min.	Typ.	Max.	Unit
順電圧 Peak Forward Voltage	$V_F$	$I_F = 50A, V_{GE} = 0V$	—	1.9	2.4	V
逆回復時間 Reverse Recovery Time	$t_{rr}$	$I_F = 50A, V_{GE} = -10V$ $di/dt = 100A/\mu\text{s}$	—	0.15	0.25	$\mu\text{s}$

□ 熱的特性 : *THERMAL CHARACTERISTICS*

Characteristic	Symbol	Test Condition	Min.	Typ.	Max.	Unit
熱抵抗 Thermal Impedance	IGBT	Junction to Case ( $T_c$ 測定点チップ直下)	—	—	0.50	$^\circ\text{C}/\text{W}$
	Diode		—	—	1.10	

Fig.1- Output Characteristics (Typical)

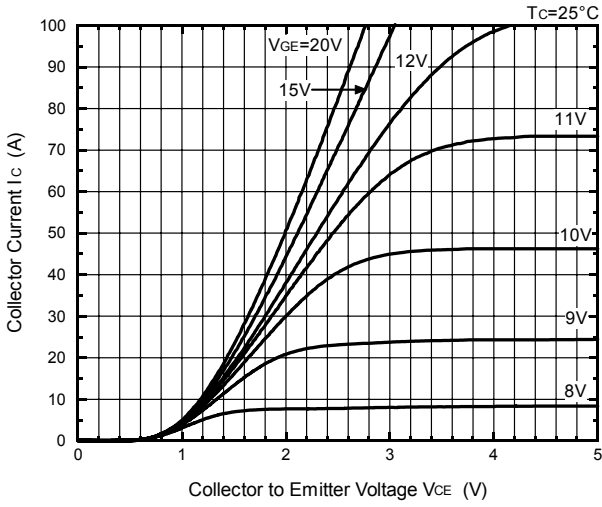


Fig.2- Output Characteristics (Typical)

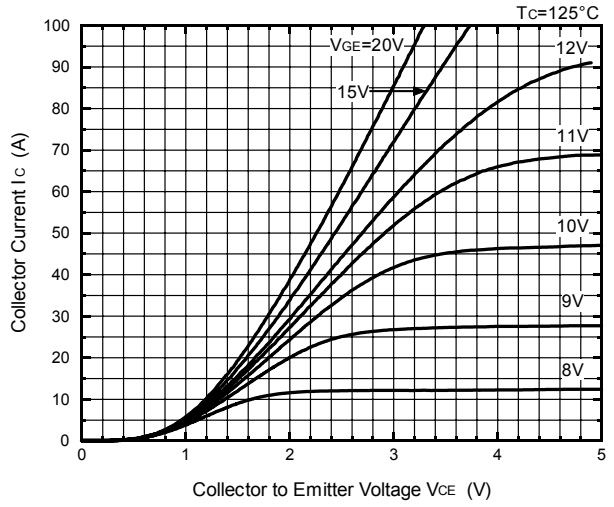


Fig.3- Collector to Emitter On Voltage vs. Gate to Emitter Voltage (Typical)

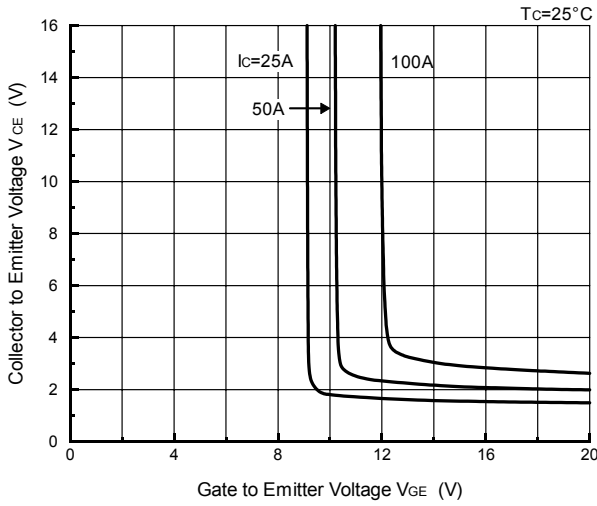


Fig.4- Collector to Emitter On Voltage vs. Gate to Emitter Voltage (Typical)

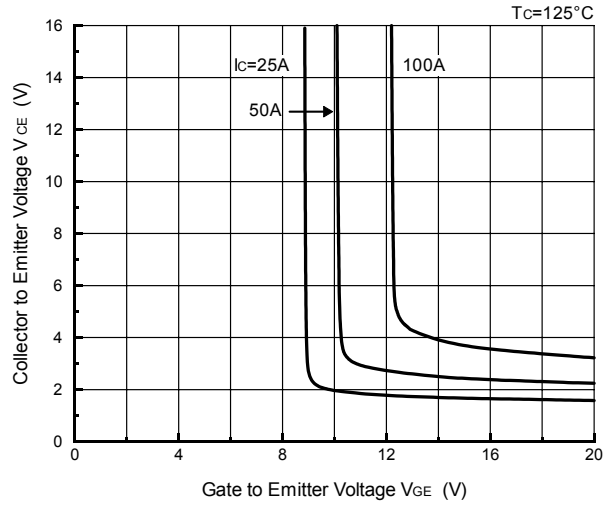


Fig.5- Gate Charge vs. Collector to Emitter Voltage (Typical)

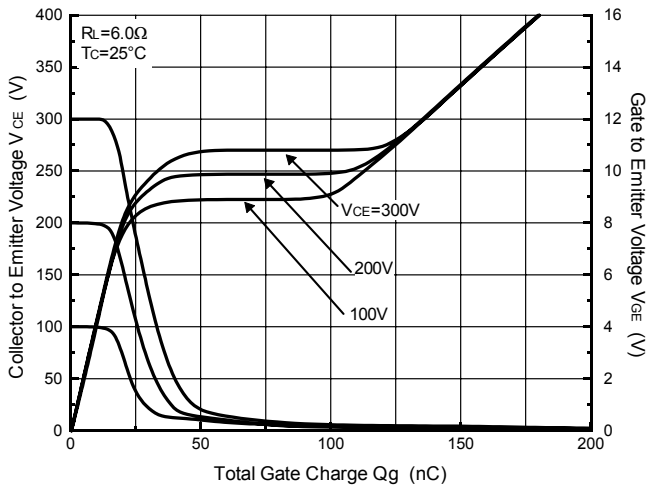
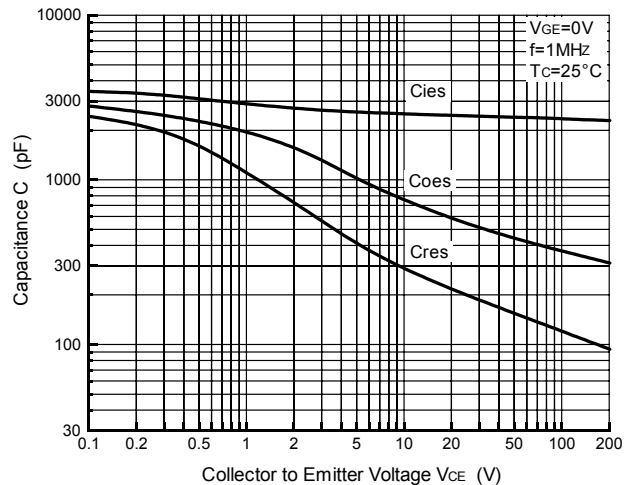
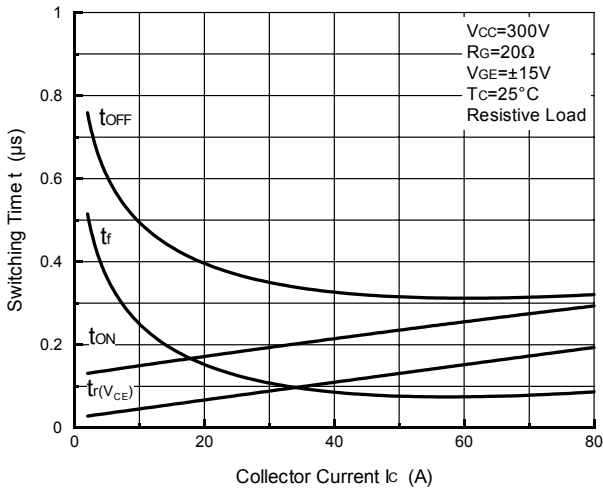


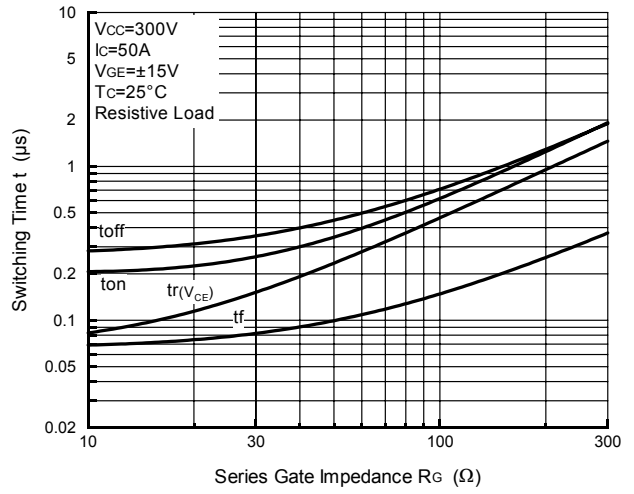
Fig.6- Capacitance vs. Collector to Emitter Voltage (Typical)



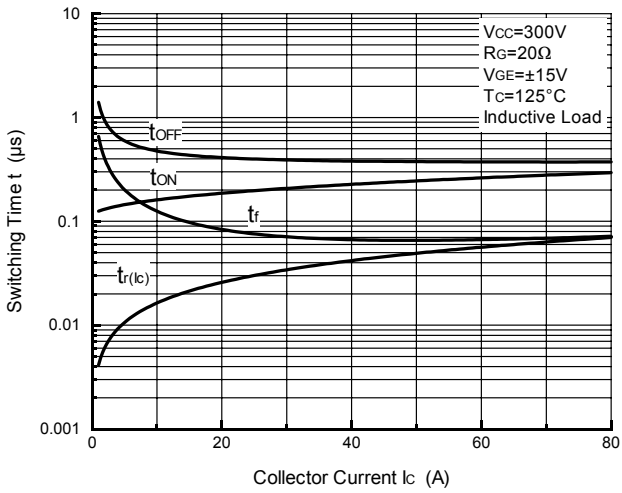
**Fig.7- Collector Current vs. Switching Time (Typical)**



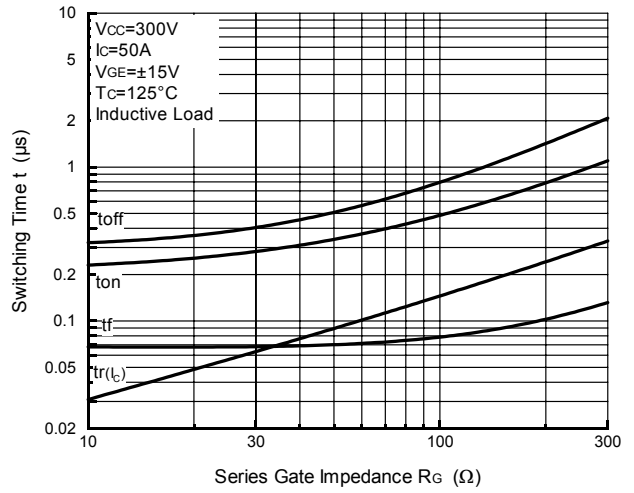
**Fig.8- Series Gate Impedance vs. Switching Time (Typical)**



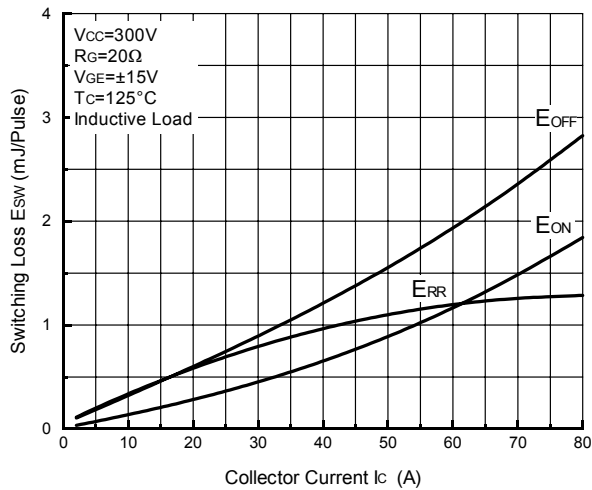
**Fig.9- Collector Current vs. Switching Time**



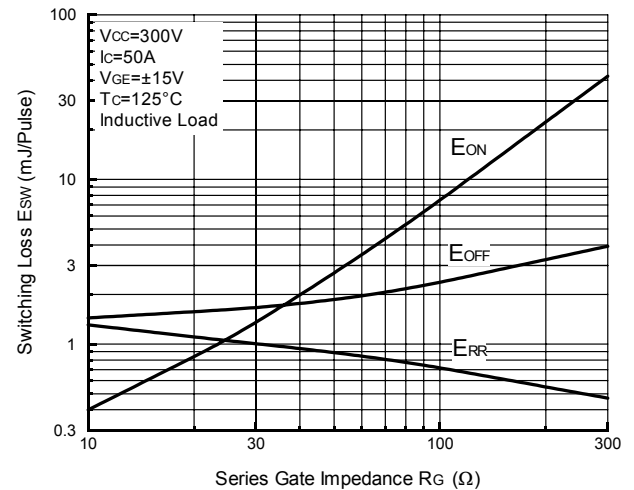
**Fig.10- Series Gate Impedance vs. Switching Time**



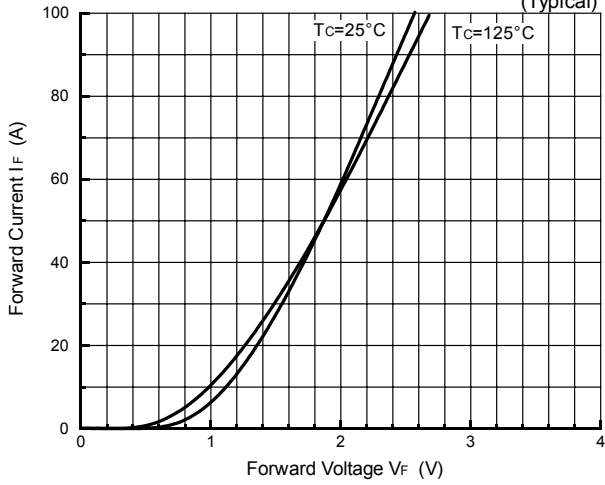
**Fig.11- Collector Current vs. Switching Loss**



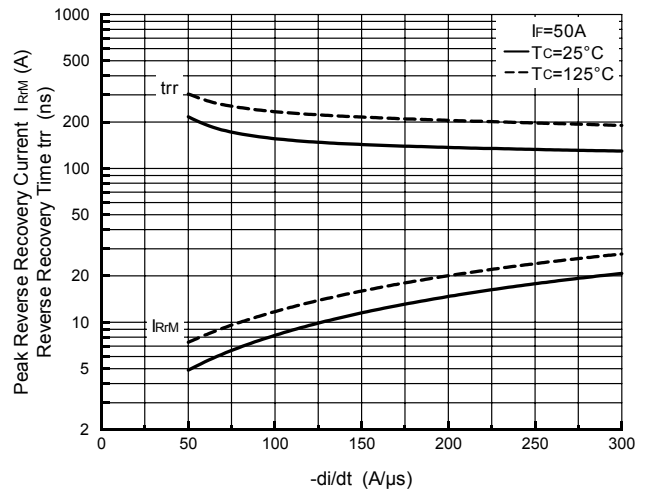
**Fig.12- Series Gate Impedance vs. Switching Loss**



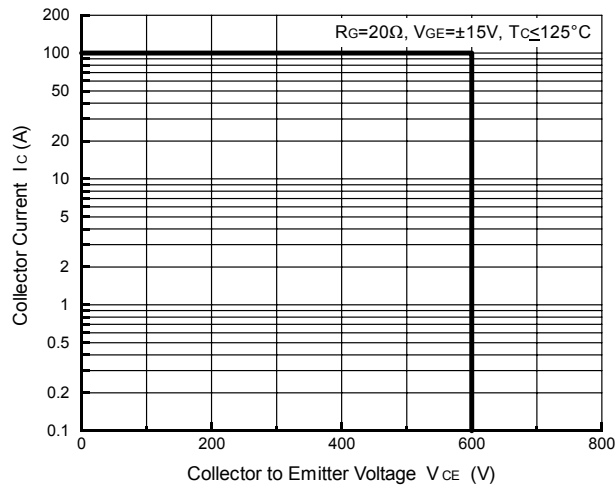
**Fig.13- Forward Characteristics of Free Wheeling Diode (Typical)**



**Fig.14- Reverse Recovery Characteristics (Typical)**



**Fig.15- Reverse Bias Safe Operating Area**



**Fig.16- Transient Thermal Impedance**

